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Appl	ication	Control	No.
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10/711,224 Examiner

Mohamed Charioui

Applicant(s)/Patent under Reexamination

HYDE ET AL.

Art Unit

2857

SEARCHED			
Class	Subclass	Date	Examiner
702	57, 60, 65, 93, 99, 116, 119	5/22/2006	мс
702	130, 136	5/22/2006	МС
702	170, 182	5/22/2006	MC ·
702	183, 189	5/22/2006	МС
702	193	5/22/2006	мс
257	59, 347	5/22/2006	. MC
257	401, 577	5/22/2006	МС
257	706	5/22/2006	мс
· 438	163	5/22/2006	МС
Search	updated ,	11/13/2006	МС
Search	updated	4/23/2007	мс
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH) ·
	DATE	EXMR
East: "silicon island" and (transistor\$1 with temperature) and (transistor\$1 with (distance or width))	5/22/2006	МС
East: "silicon island" and (transistor\$1 with temperature) and (temperature near measur\$6)	5/22/2006	МС
"silicon island" and (transistor\$1 with temperature) and (temperature near measur\$6) and diatnce	5/22/2006	MC
IEEE: search by inventor's name	5/22/2006	мс
Search updated	11/13/2006	МС
Search updated	4/23/2007	МС
Consulted with Mr. Hannaher Constantine Art Unit 2884 Class 250: No search needed	4/25/2007	MC